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# TECHNICAL SPECIFICATION



Industrial process control devices – Radiation thermometers – Part 2: Determination of the technical data for radiation thermometers

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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### CONTENTS

FO	REWC	)RD		4			
1	Scop	e	e6				
2	Norm	Normative references					
3	Term	Terms, definitions and abbreviations					
	3.1	Terms	and definitions	6			
	3.2	Abbrev	iations	9			
4	Meas	Measurement conditions					
5	Determination of technical data						
	5.1	Measuring temperature range					
		5.1.1	General				
		5.1.2	Test method	. 10			
	5.2	Measu	rement uncertainty	. 10			
		5.2.1	General	. 10			
		5.2.2	Test method	. 10			
	5.3	Noise 6	equivalent temperature difference (NETD)	.11			
		5.3.1	General	.11			
		5.3.2	Test method	.11			
	5.4	Measu	ring distance	.12			
	5.5	Field-o	f-view (target size)	.12			
		5.5.1	General	. 12			
		5.5.2	Test method	. 13			
	5.6	Distanc	ce ratio	. 14			
	5.7	Size-of-source effect (SSE)					
		5.7.1	General	. 14			
		5.7.2	Test method	. 14			
	5.8		vity setting				
	5.9	•	al range	. 15			
	5.10	Influence of the internal instrument or ambient temperature (temperature		4.5			
		•	eter)				
			General				
	E 11		Test method				
			ce of air humidity (humidity parameter)erm stability				
	5.12	•	General				
			Test method				
	5 13		erm stability				
	5.15		General				
			Test method				
	5 14		tability				
	5.14	•	General				
			Test method				
	5.15		angeability				
			General				
			Test method				
	5.16	Response time					
		•	General				
			Test method				

5.17 Exposure time .			ıre time	22			
		5.17.1	General	22			
		5.17.2	Test method	23			
	5.18	Warm-up time					
		5.18.1	General	24			
		5.18.2	Test method	24			
	5.19	Operat	ing temperature and air humidity range	25			
		5.19.1	General	25			
		5.19.2	Test method	25			
	5.20	Storage	e and transport temperature and air humidity range	26			
		5.20.1	General	26			
		5.20.2	Test method	26			
6	6 Safety requirement						
Anr	nex A	(informa	tive) Change in indicated temperature of a radiation thermometer				
cor	respor	nding to	a change in the radiation exchange	28			
Bib	liograp	ohy		29			
Fia	ure 1 -	- Relativ	ve signal to a signal at a defined aperture size (source size) of				
			ter for two infrared radiation thermometers A and B versus the source				
dia	meter			12			
Figure 2 – Demonstration of the response time to a rising temperature step20							
Fig	ure 3 -	- Possik	ole arrangement for determining the response time with two reference				
				22			
Fig	ure 4 -	- Demo	nstration of the exposure time	22			
Figure 5 – Example of warm-up time							
9							
Tak	alo A 1	The	phonon in indicated temporature corresponding to a 1.0/ shape in the				
			change in indicated temperature corresponding to a 1 % change in the ge with a radiation thermometer at 23 °C (Example)	28			
			· · · · · · · · · · · · · · · · · · ·	_			

#### INTERNATIONAL ELECTROTECHNICAL COMMISSION

## INDUSTRIAL PROCESS CONTROL DEVICES – RADIATION THERMOMETERS –

## Part 2: Determination of the technical data for radiation thermometers

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IEC 62492-2, which is a technical specification, has been prepared by subcommittee 65B: Measurement and control devices, of IEC technical committee 65: Industrial-process measurement, control and automation.

The text of this technical specification is based on the following documents:

Enquiry draft	Report on voting
65B/844/DTS	65B/859/RVC

Full information on the voting for the approval of this technical specification can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62492 series, published under the general title *Industrial process* control devices – Radiation thermometers, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- transformed into an International Standard,
- reconfirmed,
- · withdrawn,
- · replaced by a revised edition, or
- · amended.

A bilingual version of this publication may be issued at a later date.

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## INDUSTRIAL PROCESS CONTROL DEVICES – RADIATION THERMOMETERS –

## Part 2: Determination of the technical data for radiation thermometers

#### 1 Scope

This part of IEC 62492, which is a Technical Specification, applies to radiation thermometry and addresses all technical data specified in IEC/TS 62492-1. It defines standard test methods which can be used by the end user of radiation thermometers to determine or confirm the fundamental metrological data of radiation thermometers with one wavelength range and one measurement field.

The purpose of this specification is to facilitate comparability and testability. Therefore, unambiguous test methods are stipulated for determining technical data, under standardised measuring conditions that can be performed by a sufficiently skilled end user to serve as standard performance criteria for instrument evaluation or selection.

It is not compulsory for manufacturers and sellers of radiation thermometers to include all technical data given in this document in the data sheets for a specific type of radiation thermometer. Only the relevant data should be stated and should comply with this specification and IEC/TS 62492-1.

NOTE Infrared ear thermometers are excluded from this Technical Specification.

#### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC/TS 62492-1:2008, Industrial process control devices – Radiation thermometers – Part 1: Technical data for radiation thermometers